

## **IGBT** module

#### SK100GH12T4T

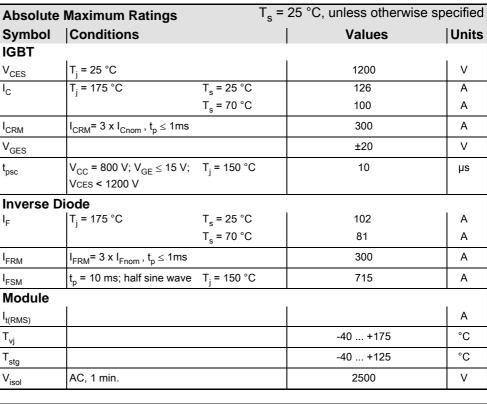
**Target Data** 

#### **Features**

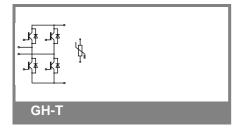
- · One screw mounting module
- Fully compatible with SEMITOP<sup>®</sup>1,2,3
- Improved thermal performances by aluminium oxide substrate
- New IGBT4 Technology
- · CAL 4 technology FWD
- Integrated NTC Temperature sensor

#### **Typical Applications**

Voltage regulator



Characteristics		$T_c$ = 25 °C, unless otherwise specified					
Symbol	Conditions		min.	typ.	max.	Units	
IGBT							
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 3.4 \text{ mA}$		5	5,8	6,5	V	
I <sub>CES</sub>	$V_{GE} = 0 V, V_{CE} = V_{CES}$	T <sub>j</sub> = 25 °C			0,02	mA	
		T <sub>j</sub> = 125 °C		0,4		mA	
I <sub>GES</sub>	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = 20 V	T <sub>j</sub> = 125 °C			1200	nA	
V <sub>CE0</sub>		T <sub>j</sub> = 25 °C		0,8	0,9	V	
		T <sub>j</sub> = 150 °C		0,7	0,8	V	
r <sub>CE</sub>	V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C		10		mΩ	
		T <sub>j</sub> = 150°C		15		mΩ	
V <sub>CE(sat)</sub>	I <sub>Cnom</sub> = 100 A, V <sub>GE</sub> = 15 V	T <sub>j</sub> = 25°C <sub>chiplev.</sub>		1,8	2	V	
		$T_j = 150^{\circ}C_{chiplev}$		2,2	2,4	V	
C <sub>ies</sub>				5,54		nF	
C <sub>oes</sub>	$V_{CE} = 25, V_{GE} = 0 V$	f = 1 MHz		0,41		nF	
C <sub>res</sub>				0,32		nF	
$Q_G$	V <sub>GE</sub> =-7V+15V			750		nC	
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C			2		Ω	
t <sub>d(on)</sub>				63		ns	
t <sub>r</sub>	$R_{Gon}$ = 16 $\Omega$	V <sub>CC</sub> = 600V		65		ns	
E <sub>on</sub>	di/dt = 1800 A/μs	I <sub>C</sub> = 100A		16,6		mJ	
$t_{d(off)}$	$R_{Goff} = 16 \Omega$	T <sub>j</sub> = 150 °C		521		ns	
t <sub>f</sub>	di/dt = 1800 A/μs			80		ns	
E <sub>off</sub>				10		mJ	
$R_{th(j-s)}$	per IGBT			0,43		K/W	





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## **Typical Applications**

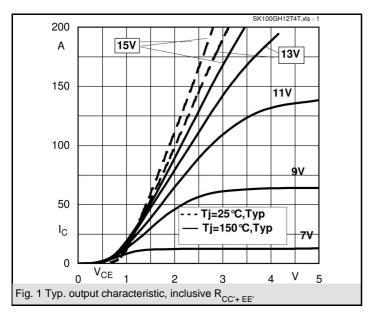
Voltage regulator

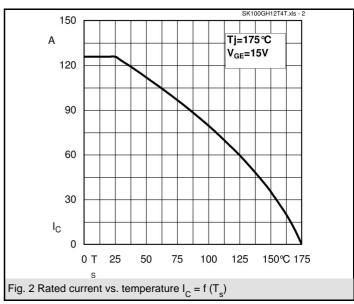
Characteristics										
Symbol	Conditions		min.	typ.	max.	Units				
Inverse Diode										
$V_F = V_{EC}$	I <sub>Fnom</sub> = 100 A; V <sub>GE</sub> = 0 V	$T_j = 25  ^{\circ}C_{\text{chiplev.}}$		2,2	2,5	V				
		$T_j = 150  ^{\circ}C_{\text{chiplev.}}$		2,1	2,45	V				
V <sub>F0</sub>		T <sub>j</sub> = 25 °C		1,3	1,5	V				
		T <sub>j</sub> = 150 °C		0,9	1,1	V				
r <sub>F</sub>		T <sub>j</sub> = 25 °C		9,5	10,5	mΩ				
		T <sub>j</sub> = 150 °C T <sub>j</sub> = 150 °C		13	14	$\text{m}\Omega$				
I <sub>RRM</sub>	I <sub>F</sub> = 100 A	T <sub>j</sub> = 150 °C		52		Α				
$Q_{rr}$	di/dt = 1800 A/µs	-		14		μC				
E <sub>rr</sub>	V <sub>CC</sub> =600V			5,2		mJ				
$R_{th(j-s)D}$	per diode			0,62		K/W				
Freewhee	ling Diode									
$V_F = V_{EC}$	$I_{Fnom} = A; V_{GE} = V$	$T_j = {^{\circ}C_{chiplev.}}$				V				
V <sub>F0</sub>		T <sub>j</sub> = °C				V				
r <sub>F</sub>		$T_j = ^{\circ}C$ $T_i = ^{\circ}C$				V				
I <sub>RRM</sub>	I <sub>F</sub> = A	T <sub>j</sub> = °C				Α				
$Q_{rr}$		-				μC				
E <sub>rr</sub>						mJ				
	per diode					K/W				
$M_s$	to heat sink		2,5		2,75	Nm				
w				60		g				
Temperature sensor										
R <sub>100</sub>	$T_s = 100^{\circ}C (R_{25} = 5k\Omega)$			493±5%		Ω				

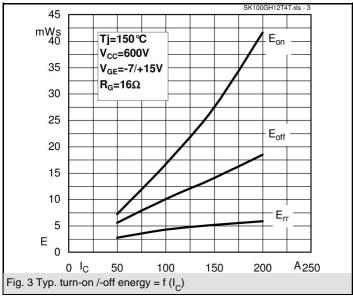
This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

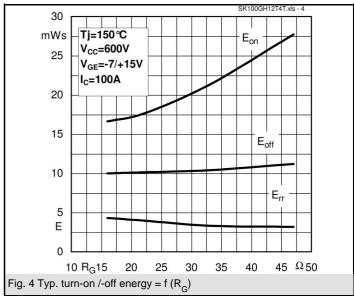
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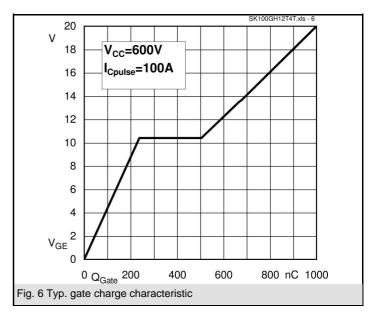


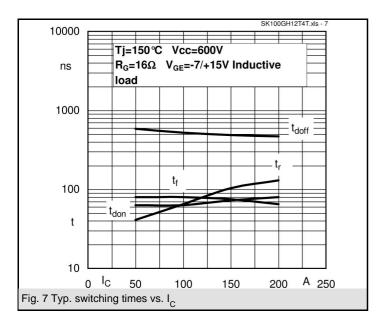


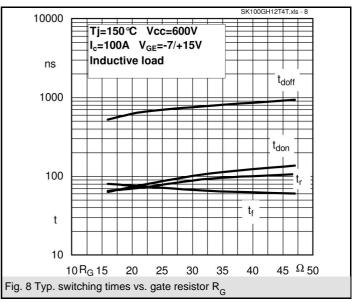


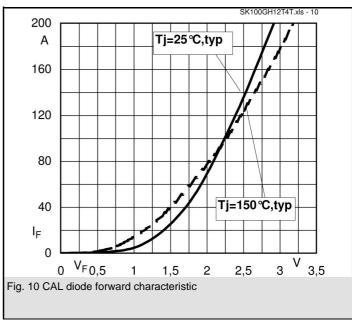


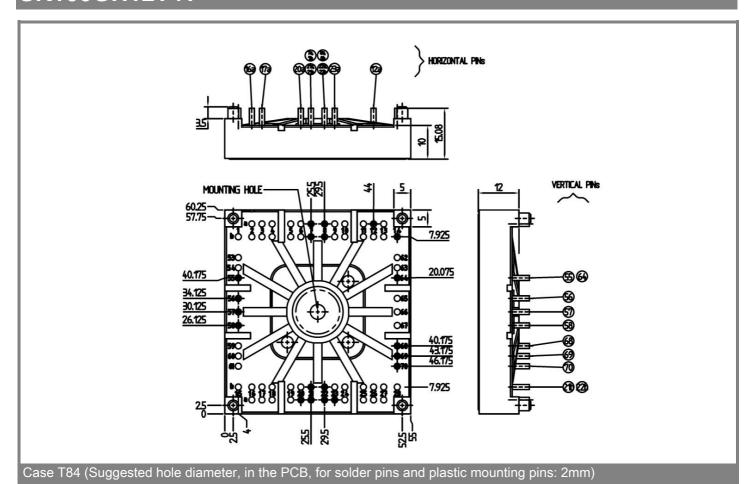


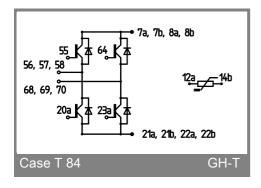












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